MCAE214: PATTERN RECOGNITION

Hours/Week: 3 I.A. Marks: 30 Credits: 3 Exam. Marks: 70

Course Learning objectives: Students will try,

- 1. Understand the concept of a pattern and the basic approach to the development of pattern recognition and machine intelligence algorithms
- 2. Understand the basic methods of feature extraction, feature evaluation, and data mining
- 3. Understand and apply both supervised and unsupervised classification methods
- 4. To detect and characterize patterns in real-world data.

Course Outcomes: After completing the course, the students will be able to,

- CO1: Design and implement machine learning solutions to classification, regression, and clustering.
- CO2: Evaluate and interpret the results of the algorithms.
- CO3: Search, collect, classify and critically interpret relevant information to design a simple pattern recognition systems
- CO4: Describe and explain a pattern recognition algorithm that utilizes supervised learning and unsupervised learning
- CO5: Gain knowledge about state-of-the-art algorithms used in pattern recognition research.
- CO6: Apply pattern recognition techniques in practical problems.
- C07: Realize the importance of the various feature selection algorithms usages.

UNIT-I 9 Hrs.

Pattern Recognition Systems – Definitions, data representation, representations of patterns and classes. Types of pattern recognition systems. Applications of pattern recognition systems. Bayesian decision making and Bayes Classifier for continuous and discrete features.

UNIT-II ನವೇ-ಬೆಳ್ಳಾ 9 Hrs.

Min-max and Neymann-Pearson classifiers, Discriminant functions, decision surfaces. Maximum likelihood estimation and Bayesian parameter estimation. Overview of Nonparametric density estimation – Histogram based approach, classification using Parzen window.

UNIT-III 9 Hrs.

K-nearest neighbour Estimation and Classification. Classification of Clustering Algorithms – Hierarchical Clustering – Agglomerative Clustering. Partitional Clustering – Forgy's algorithm, K-means Clustering.

UNIT-IV 9 Hrs.

Introduction to Feature Selection – Filter Method – Sequential Forward and Backward Selection Algorithms. Wrappers Method and Embedded Methods. Feature Extraction Methods – Principal Component Analysis, Fisher Linear Discriminant Analysis, ICA.

REFERENCE BOOKS:

- 1. R. J. Schalkoff, Pattern Recognition: Statistical, Structural and Neural approaches, Wiley Student Edn, 1992.
- 2. Tou and Gonzalez, Pattern Recognition Principles, Addison Wesley, 1974.
- 3. Duda, Hart and Stork, Pattern Classification, 2ndEdn, John Wiley and Sons
- 4. Morton Nadler, Eric P Smith, Pattern Recognition Engineering, Wiley, 1993.
- 5. Duda R.O., Hart P.E., Stork D.G., Pattern Classification, John Wiley and Sons, 2nd Edition, 2001
- 6. Bishop C.M., Pattern Recognition and Machine Learning, Springer, 2nd Edition, 2006
- 7. Theodoridis S., Pikrakis A., Koutroumbas K., Cavouras D., Introduction to Pattern Recognition: A MATLAB approach, Academic Press, 2010.

